

Search Notes

Application/Control No.

10/821,505

Examiner

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Applicant(s)/Patent under
Reexamination

HUANG ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	4	1/12/2006	JSL
716	5	1/12/2006	JSL
716	6	1/12/2006	JSL
702	181	1/12/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	1/12/2006	JSL
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	1/17/2006	JSL
IEEE	1/17/2006	JSL